

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/764,567	OHZU ET AL.	
	Examiner	Art Unit	
	Felix E. Suarez	2857	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
702	29, 128	5/25/2006	FS
702	149, 150	5/25/2006	FS